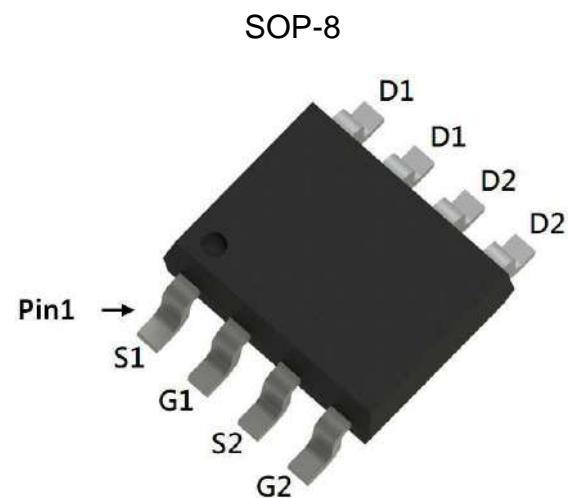


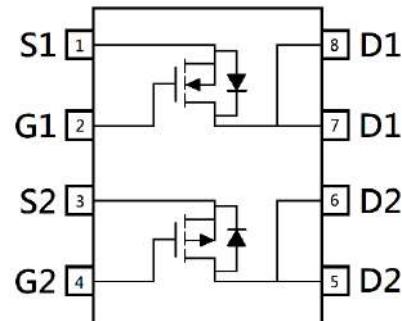
N- AND P-Channel Enhancement Mode Power MOSFET

Features:

- Simple drive requirement
- Low On Resistance
- Low Gate Charge
- Fast switching speed



	N-CH	P-CH
BV _{DSS}	20V	-20V
I _D @V _{GS} =(-)4.5V, T _c =25°C	12A	-6.9A
I _D @V _{GS} =(-)4.5V, T _A =25°C	6.4A	-3.5A
R _{DS(ON)typ.} @ V _{GS} =(-)4.5V	16mΩ	60mΩ
R _{DS(ON)typ.} @ V _{GS} =(-)2.5V	19mΩ	75mΩ



G : Gate S : Source D : Drain

Ordering Information

Device	Package	Shipping
KSCA015C02	SOP-8 (RoHS compliant & Halogen-free package)	4000 pcs / Tape & Reel

Absolute Maximum Ratings ($T_A=25^\circ C$)

Parameter	Symbol	Limits		Unit
		N-CH	P-CH	
Drain-Source Voltage	V_{DS}	20	-20	V
Gate-Source Voltage	V_{GS}	± 8	± 8	
Continuous Drain Current @ $V_{GS}=(-)4.5V$, $T_C=25^\circ C$	I_D	12	-6.9	A
Continuous Drain Current @ $V_{GS}=(-)4.5V$, $T_C=100^\circ C$		8	-4.4	
Continuous Drain Current @ $V_{GS}=(-)4.5V$, $T_A=25^\circ C$		6.4	-3.5	
Continuous Drain Current @ $V_{GS}=(-)4.5V$, $T_A=70^\circ C$		5.1	-2.8	
Pulsed Drain Current	I_{DM}	48	-27	A
Continuous Body Diode Forward Current @ $T_C=25^\circ C$	I_S	4.6	-4.6	
Avalanche Current @ $L=0.1mH$	I_{AS}	12	-8	
Avalanche Energy @ $L=0.5mH$	E_{AS}	9	6	mJ
Total Power Dissipation	$T_C=25^\circ C$	P_D	5.6	W
	$T_C=100^\circ C$		2.2	
	$T_A=25^\circ C$		1.4	
	$T_A=70^\circ C$		0.9	
Operating Junction and Storage Temperature Range	T_J, T_{stg}	$-55\text{~}+150$		°C

Thermal Data

Parameter	Symbol	Steady State	Unit
Thermal Resistance, Junction-to-case	$R_{\theta JC}$	22	°C/W
Thermal Resistance, Junction-to-ambient	$R_{\theta JA}$	86	

Note:

- *a. The power dissipation P_D is based on $T_{J(MAX)}=150^\circ C$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- *b. The value of $R_{\theta JA}$ is measured with the device mounted on 1 in² FR -4 board with 2 oz. copper, in a still air environment with $T_A=25^\circ C$. The power dissipation P_D is based on $R_{\theta JA}$ and the maximum allowed junction temperature of $150^\circ C$. The value in any given application depends on the user's specific board design.
- *c. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}=150^\circ C$. Ratings are based on low frequency and low duty cycles to keep initial $T_J=25^\circ C$.

N-Channel Electrical Characteristics ($T_A=25^\circ C$, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions	
Static						
BV _{DSS}	20	-	-	V	V _{GS} =0V, I _D =250μA	
V _{GS(th)}	0.3	-	1		V _{DS} =V _{GS} , I _D =250μA	
G _{FS}	-	12	-	S	V _{DS} =5V, I _D =3A	
I _{GSS}	-	-	±100	nA	V _{GS} =±8V, V _{DS} =0V	
I _{DSS}	-	-	1	μA	V _{DS} =16V, V _{GS} =0V	
R _{DSS(ON)}	-	16	20	mΩ	V _{GS} =4.5V, I _D =6A	
	-	19	30		V _{GS} =2.5V, I _D =4A	
Dynamic						
C _{iss}	-	700	-	pF	V _{DS} =10V, V _{GS} =0V, f=1MHz	
C _{oss}	-	95	-			
C _{rss}	-	87	-	nC	V _{DS} =10V, I _D =3A, V _{GS} =4.5V	
R _g	-	0.9	-			
Q _g *1, 2	-	10	-	ns	V _{DS} =10V, I _D =1A, V _{GS} =4.5V, R _{GS} =10Ω	
Q _{gs} *1, 2	-	1.1	-			
Q _{gd} *1, 2	-	2.8	-	ns	V _{DS} =10V, I _D =1A, V _{GS} =4.5V, R _{GS} =10Ω	
t _{d(ON)} *1, 2	-	8.2	-			
t _r *1, 2	-	20	-	ns	I _F =1A, dI _F /dt=100A/μs	
t _{d(OFF)} *1, 2	-	38	-			
t _f *1, 2	-	16	-	ns	I _F =1A, dI _F /dt=100A/μs	
Source-Drain Diode						
V _{SD} *1	-	0.82	1.2	V	I _s =3A, V _{GS} =0V	
tr	-	8	-	ns	I _F =1A, dI _F /dt=100A/μs	
Q _{rr}	-	3	-			

Note:

*1. Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

*2. Independent of operating temperature

P-Channel Electrical Characteristics ($T_A=25^\circ C$, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions	
Static						
BV _{DSS}	-20	-	-	V	V _{GS} =0V, I _D =-250μA	
V _{GS(th)}	-0.4	-	-1.3		V _{DS} =V _{GS} , I _D =-250μA	
G _{FS}	-	6	-	S	V _{DS} =-5V, I _D =-2A	
I _{GSS}	-	-	±100	nA	V _{GS} =±8V, V _{DS} =0V	
I _{DSS}	-	-	-1	μA	V _{DS} =-16V, V _{GS} =0V	
R _{DSS(ON)}	-	60	78	mΩ	V _{GS} =-4.5V, I _D =-3.5A	
	-	75	105		V _{GS} =-2.5V, I _D =-2A	
Dynamic						
C _{iss}	-	660	-	pF	V _{DS} =-10V, V _{GS} =0V, f=1MHz	
C _{oss}	-	60	-			
C _{rss}	-	58	-	nC	V _{DS} =-10V, I _D =-2A, V _{GS} =-4.5V	
R _g	-	13.7	-			
Q _g *1, 2	-	7.8	-	nC	V _{DS} =-10V, I _D =-2A, V _{GS} =-4.5V	
Q _{gs} *1, 2	-	1	-			
Q _{gd} *1, 2	-	1.6	-	ns	V _{DS} =-10V, I _D =-1A, V _{GS} =-5V, R _{gs} =3.3Ω	
t _{d(ON)} *1, 2	-	5	-			
t _r *1, 2	-	17	-	ns	V _{DS} =-10V, I _D =-1A, V _{GS} =-5V, R _{gs} =3.3Ω	
t _{d(OFF)} *1, 2	-	48	-			
t _f *1, 2	-	6	-			
Source-Drain Diode						
V _{SD} *1	-	-0.85	-1.2	V	I _s =-2A, V _{GS} =0V	
tr	-	6.2	-	ns	I _F =-2A, dI _F /dt=100A/μs	
Q _{rr}	-	2.3	-	nC		

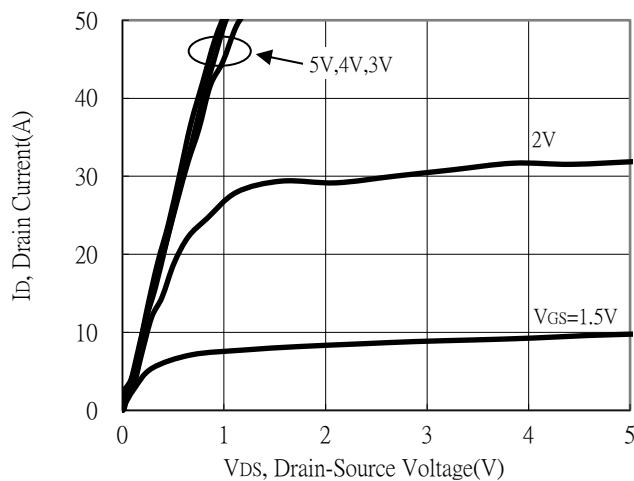
Note:

*1. Pulse Test : Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$

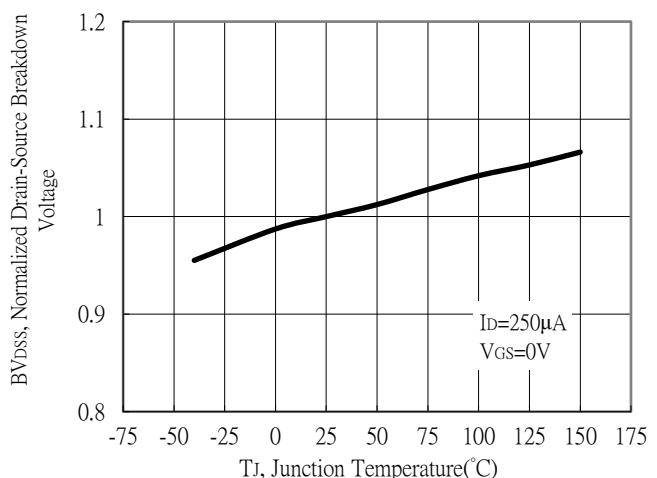
*2. Independent of operating temperature

Typical Characteristics : Q1(N-channel)

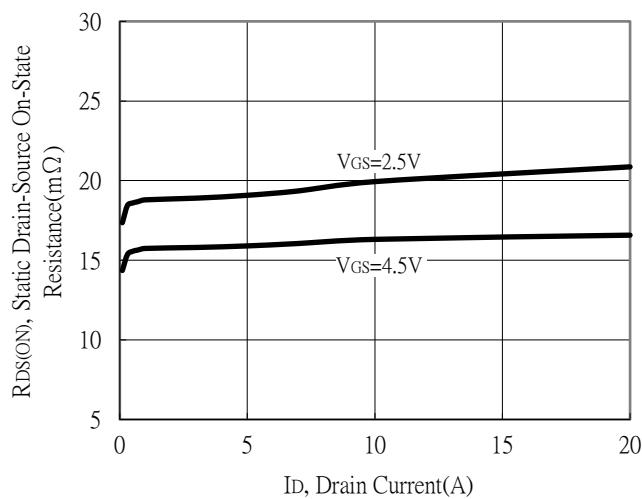
Typical Output Characteristics



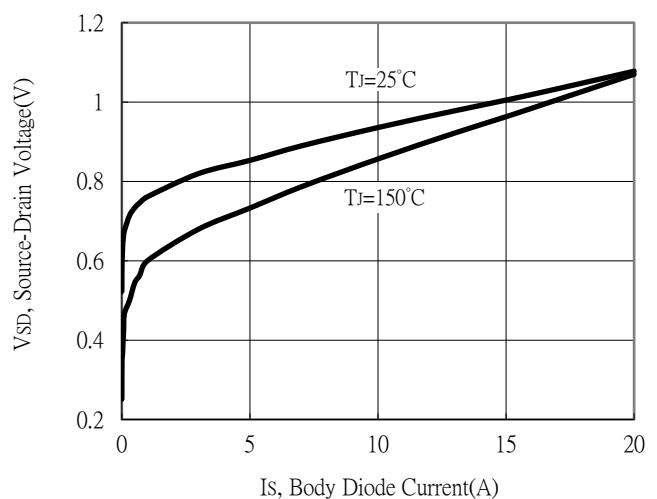
Breakdown Voltage vs Ambient Temperature



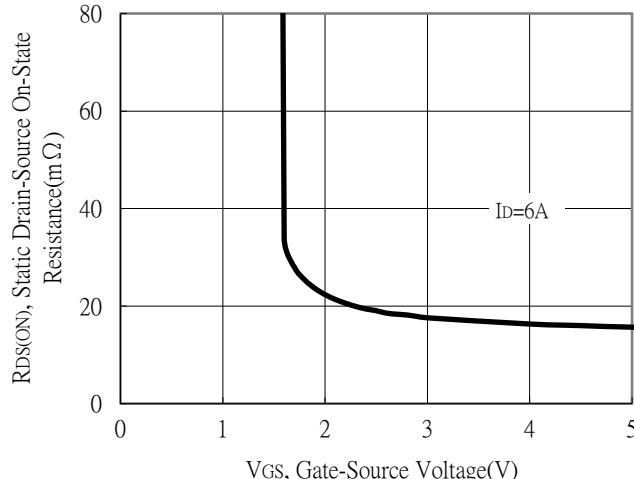
Static Drain-Source On-State resistance vs Drain Current



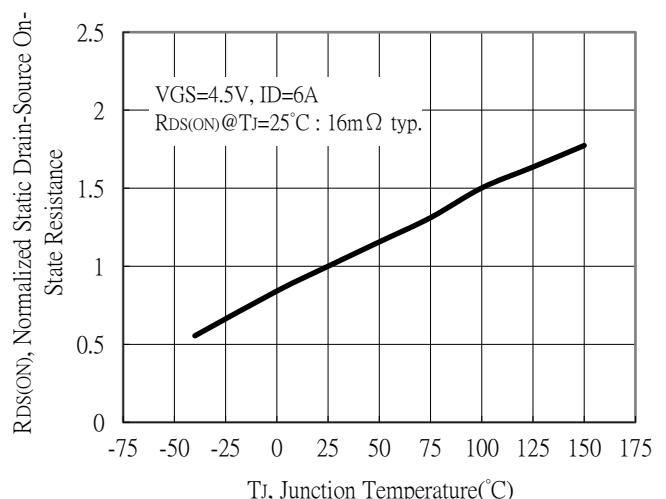
Body Diode Current vs Source-Drain Voltage



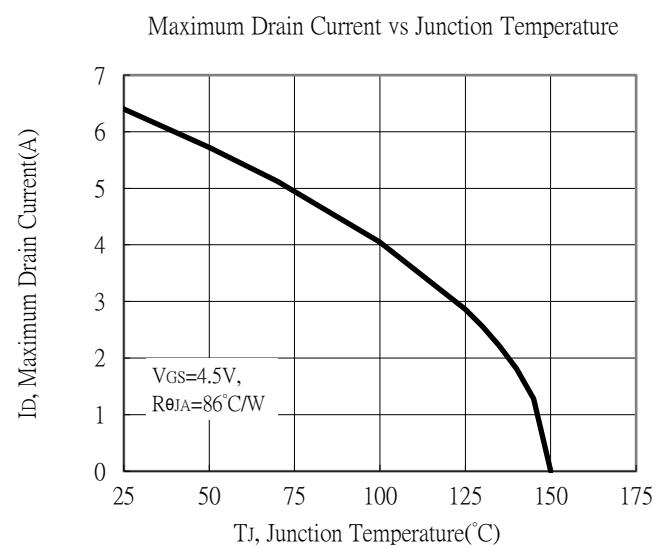
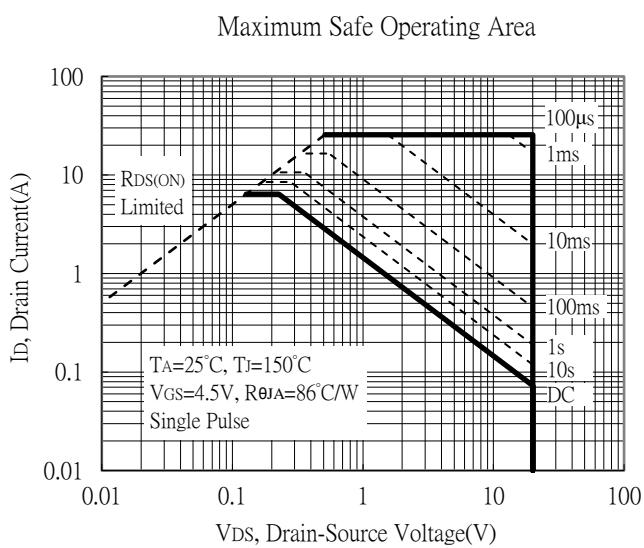
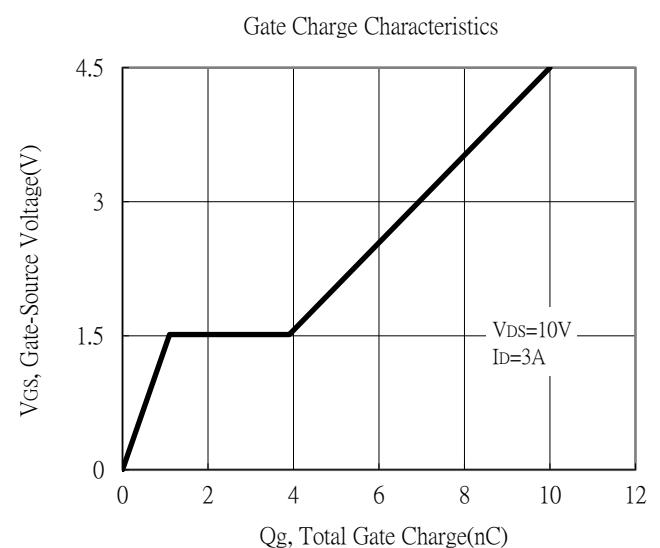
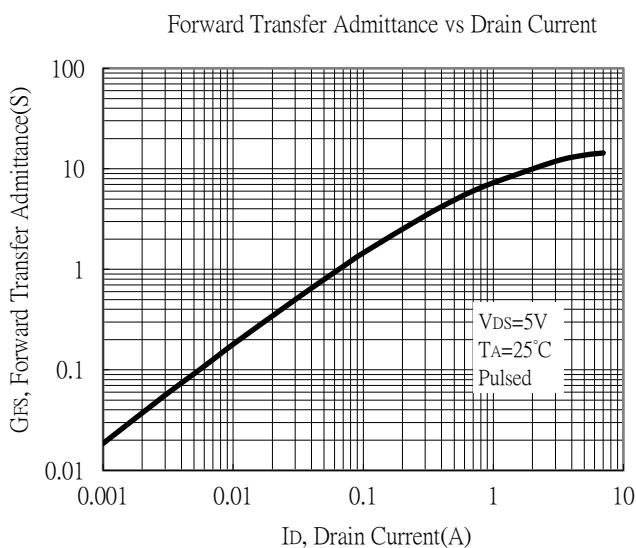
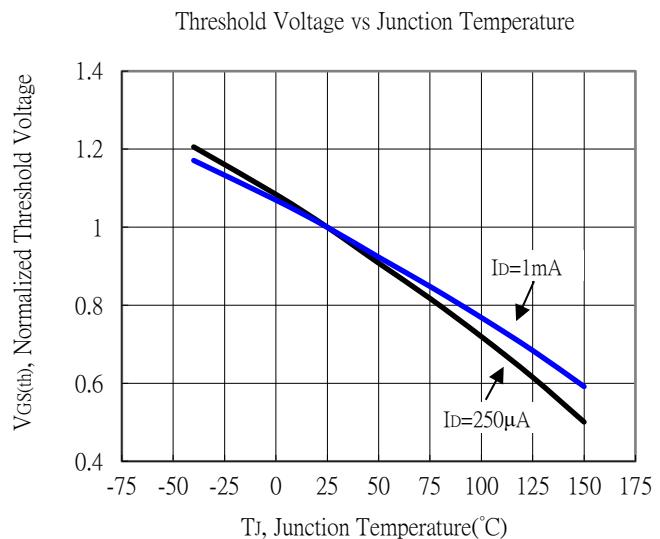
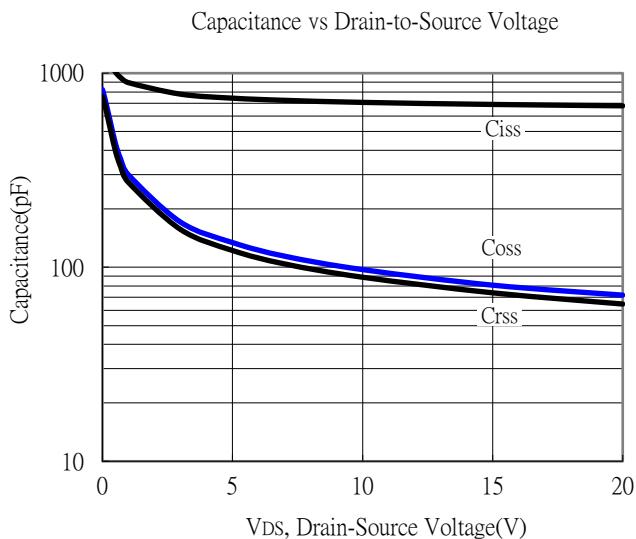
Static Drain-Source On-State Resistance vs Gate-Source Voltage



Drain-Source On-State Resistance vs Junction Temperature

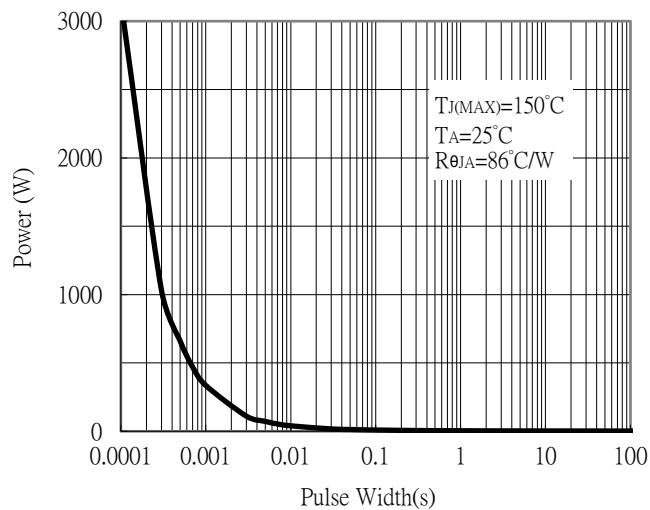


Typical Characteristics (Cont.) : Q1(N-channel)

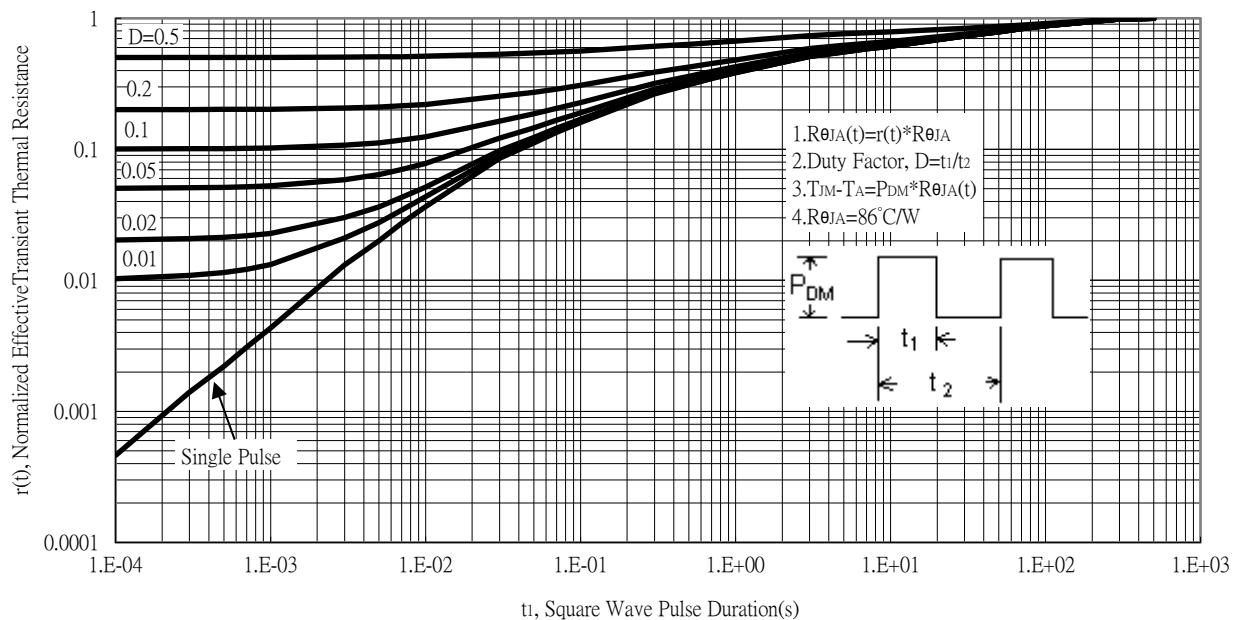


Typical Characteristics (Cont.) : Q1(N-channel)

Single Pulse Power Rating, Junction to Ambient

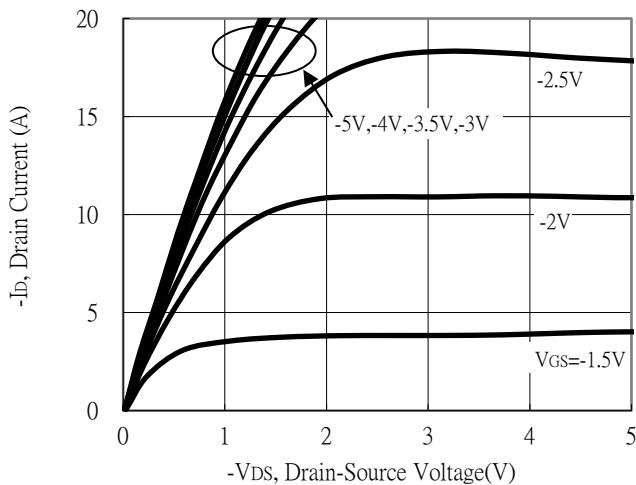


Transient Thermal Response Curves

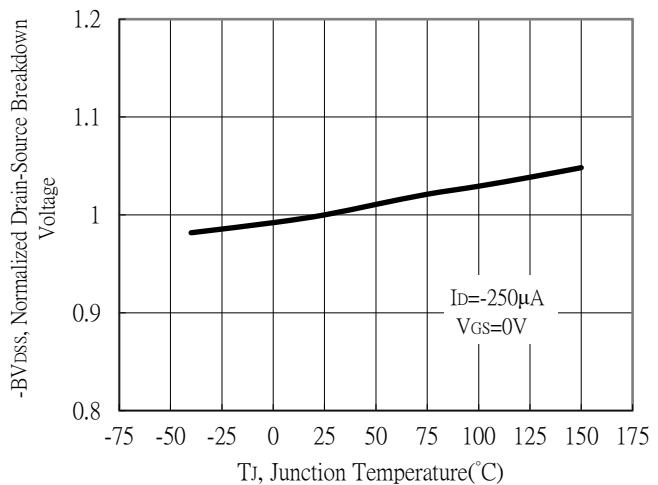


Typical Characteristics : Q2(P-channel)

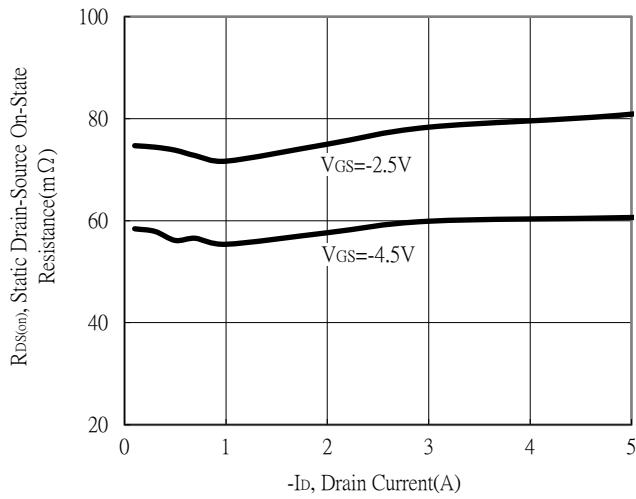
Typical Output Characteristics



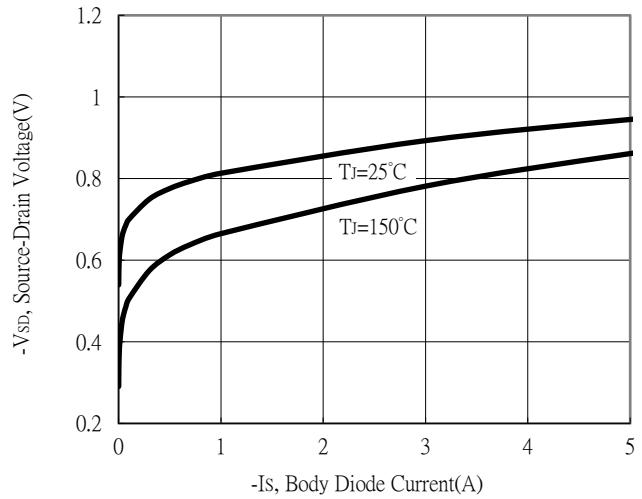
Breakdown Voltage vs Ambient Temperature



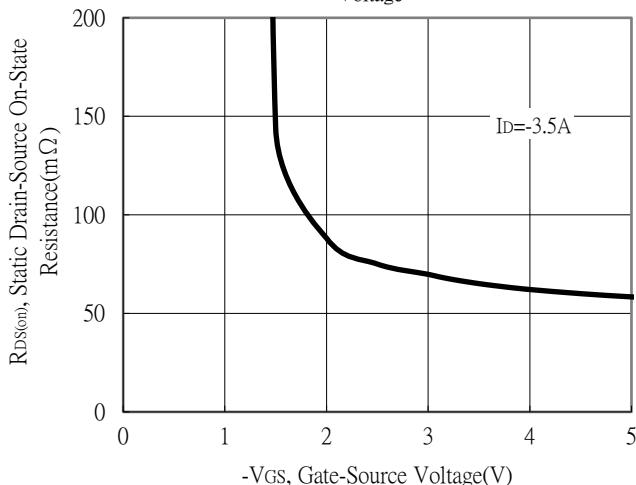
Static Drain-Source On-State resistance vs Drain Current



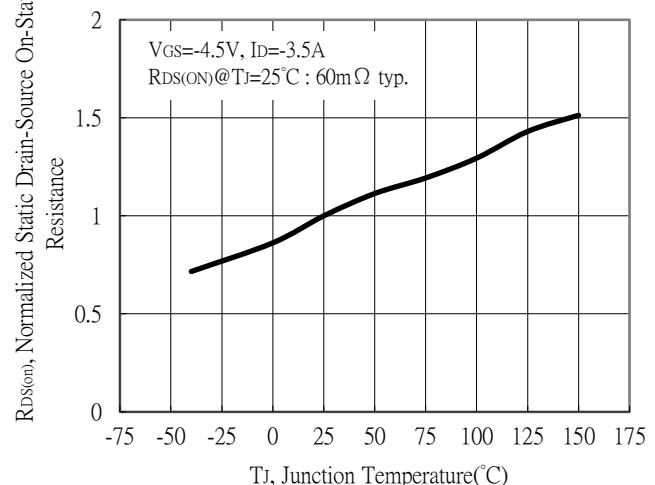
Body Diode Current vs Source-Drain Voltage



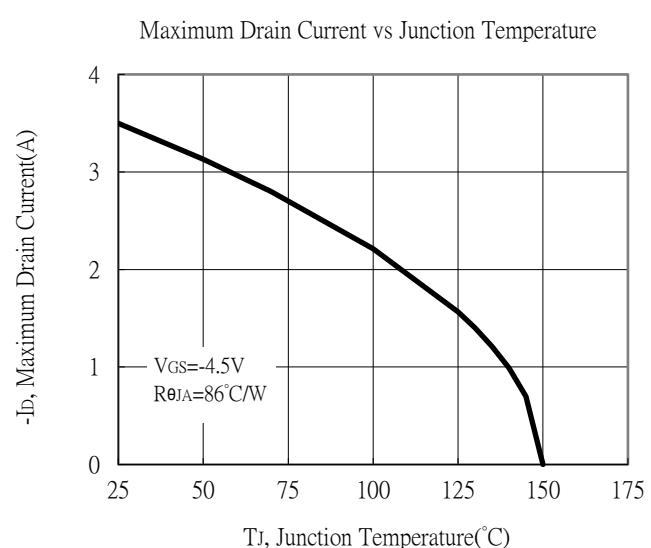
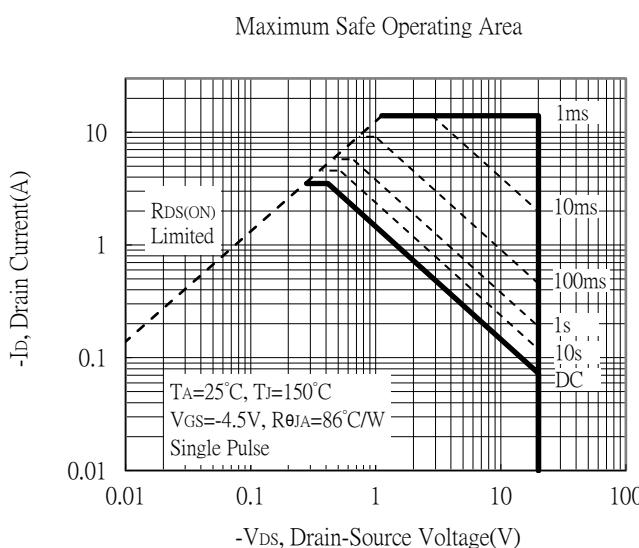
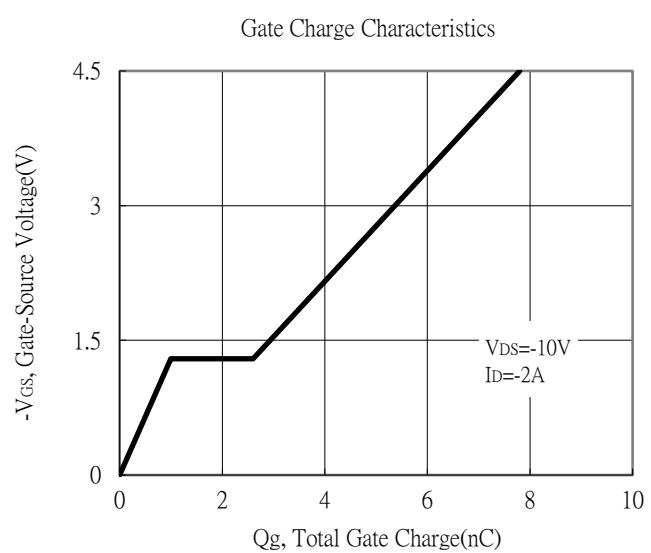
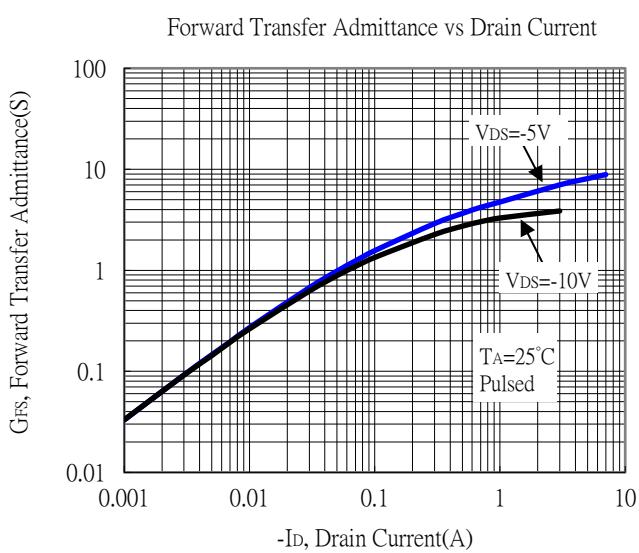
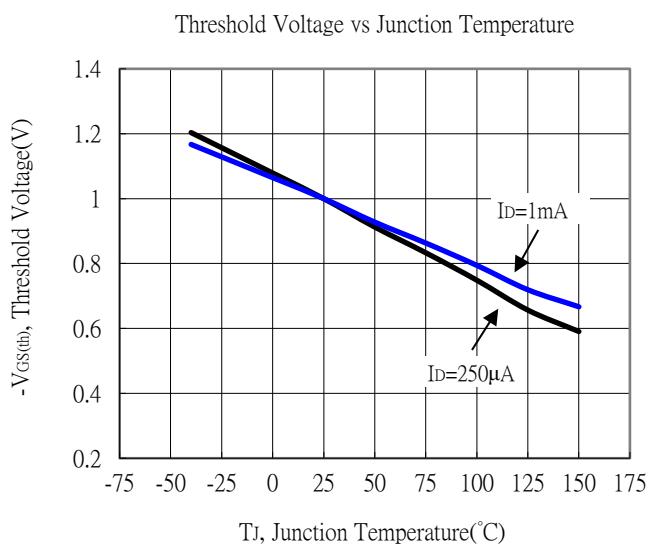
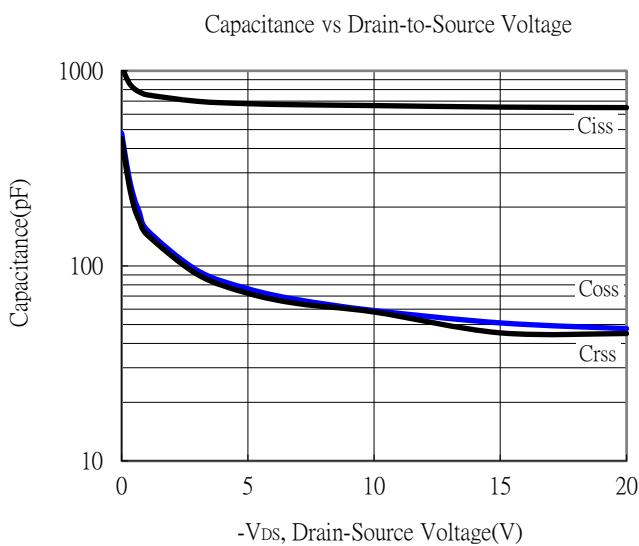
Static Drain-Source On-State Resistance vs Gate-Source Voltage



Drain-Source On-State Resistance vs Junction Temperature

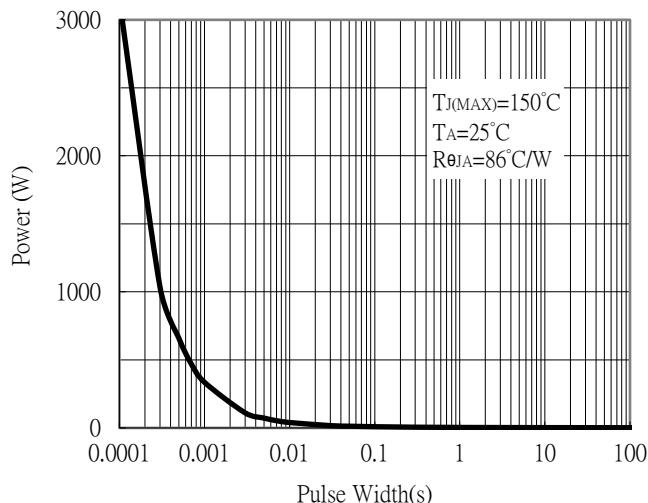


Typical Characteristics (Cont.) : Q2(P-channel)

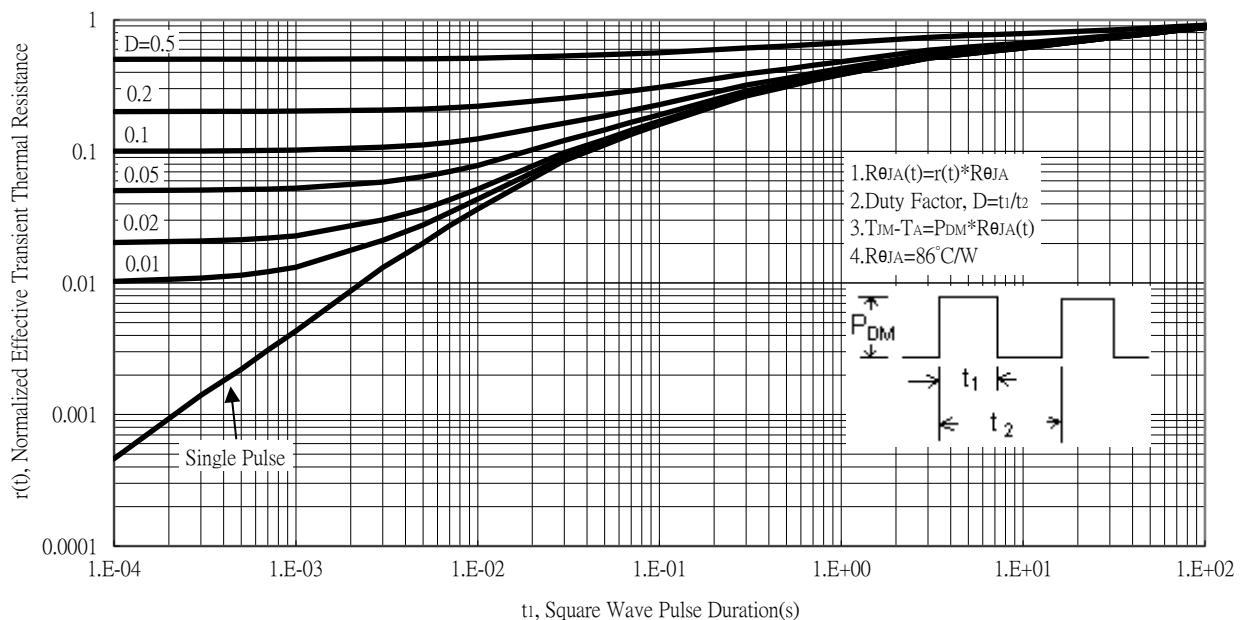


Typical Characteristics (Cont.) : Q2(P-channel)

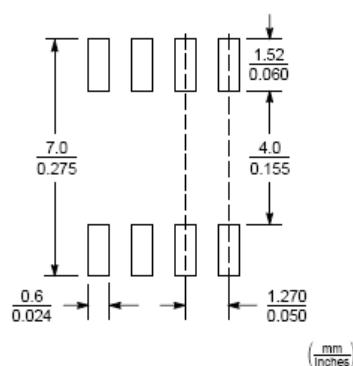
Single Pulse Power Rating, Junction to Ambient



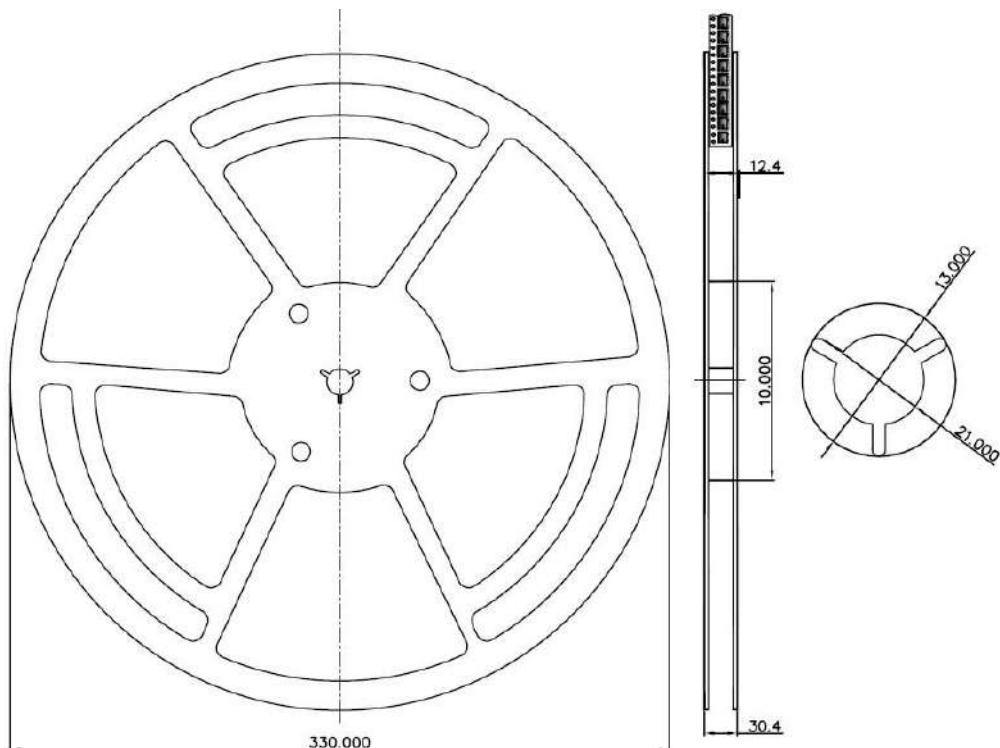
Transient Thermal Response Curves



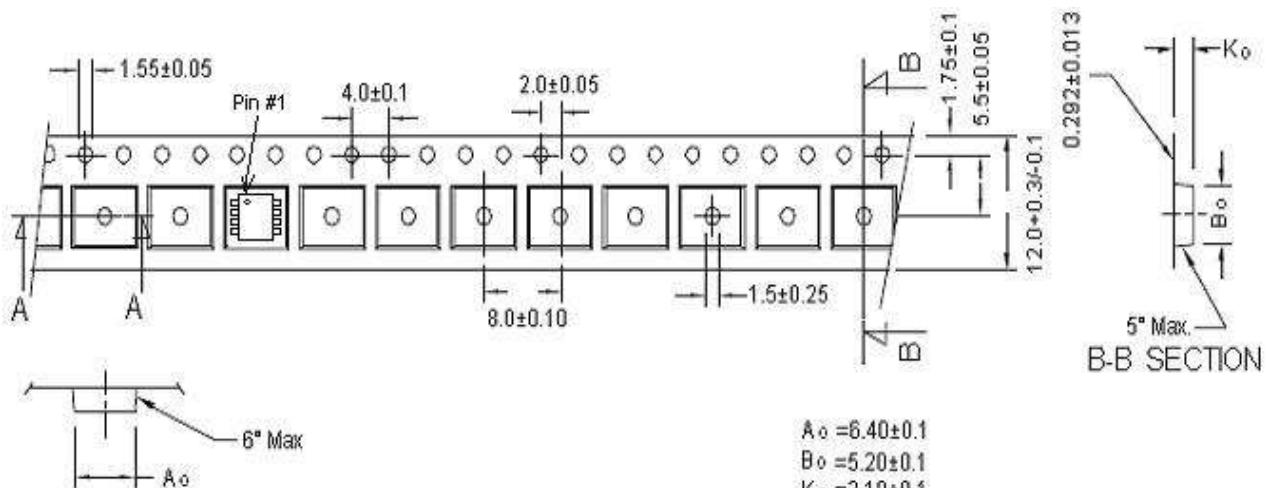
Recommended Soldering Footprint



Reel Dimension



Carrier Tape Dimension



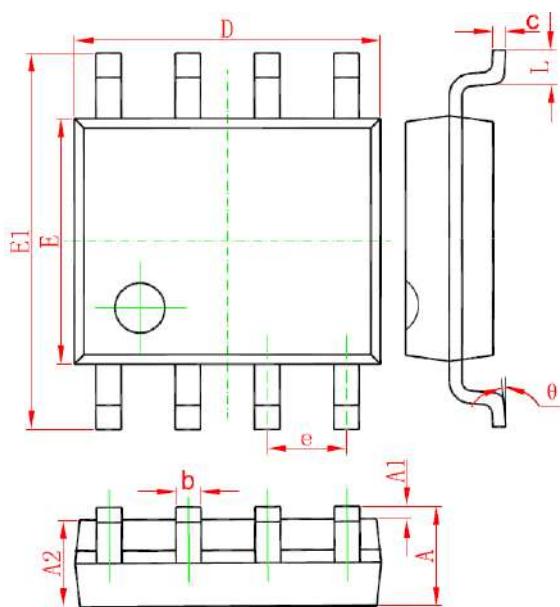
A-A SECTION

Notes:

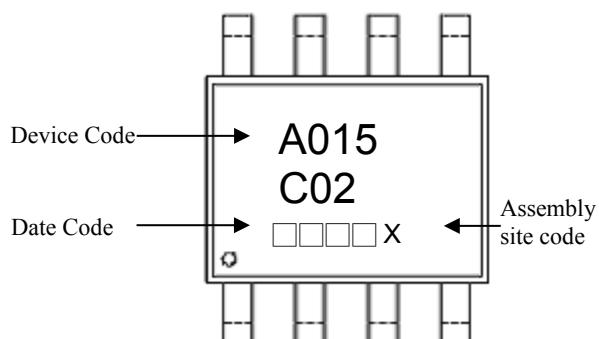
1. 10 sprocket hole pitch cumulative tolerance ± 0.2 .
2. Camber not to exceed 1mm in 100mm.
3. Material: conductive black polystyrene
4. Ao & Bo measured on a plane 0.3mm above the bottom of the pocket.
5. Ko measured from a plane on the inside bottom of the pocket to the top surface of the carrier.
6. Pocket position relative to sprocket hole measured as true position of pocket, not pocket hole.

Unit : millimeter

SOP-8 Dimension



Marking:



Date Code(counting from left to right) :

1st code: year code, the last digit of Christian year

2nd code : month code, Jan→A, Feb→B, Mar→C, Apr→D

May→E, Jun→F, Jul→G, Aug→H, Sep→J,
 Oct→K, Nov→L, Dec→M

3rd and 4th codes : production serial number, 01~99

Assembly site code : blank→ site 1, G →site 2

8-Lead SOP-8 Plastic Package

*: Typical

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	1.350	1.750	0.053	0.069	E	3.800	4.000	0.150	0.157
A1	0.100	0.250	0.004	0.010	E1	5.800	6.200	0.228	0.244
A2	1.350	1.550	0.053	0.061	e	*1.270		*0.050	
b	0.330	0.510	0.013	0.020	L	0.400	1.270	0.016	0.050
c	0.170	0.250	0.006	0.010	θ	0°	8°	0°	8°
D	4.700	5.100	0.185	0.200					